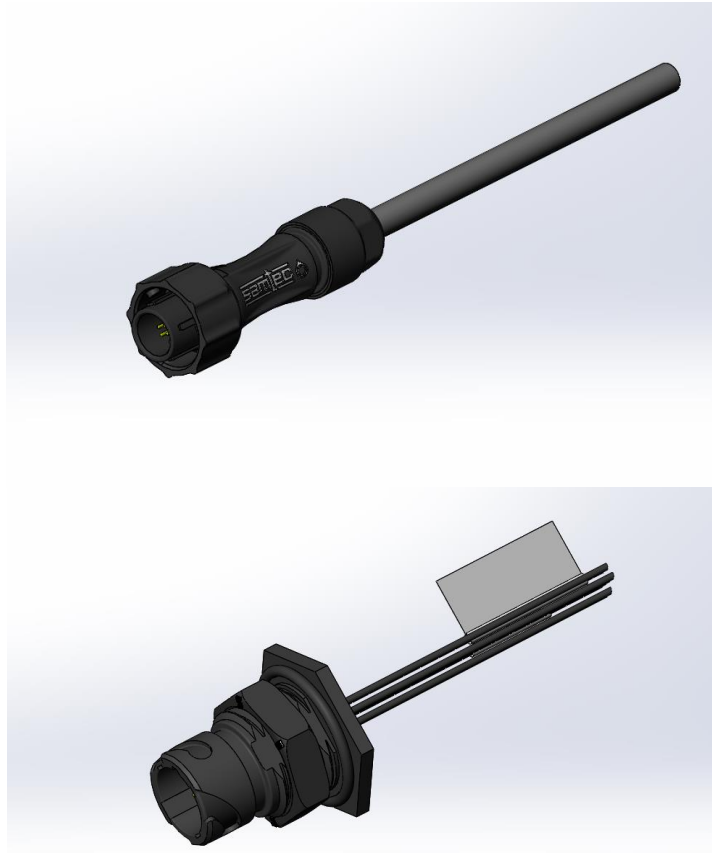




Project Number: Design Qualification Test Report	Tracking Code: 728544_Report_Rev_1
Requested by: Vision Liu	Date: 4/18/2016
Part #: CCP-12-1-L-00.3-S-B-P/CCR-12-1-L-00.3-T-B-P	Tech: Peter Chen
Part description: CCP/CCR	Qty to test: 100
Test Start: 11/20/2015	Test Completed: 12/30/2015



DESIGN QUALIFICATION TEST REPORT

**CCP-12-1-L-00.3-S-B-P/CCR-12-1-L-00.3-T-B-P
CCP/CCR**

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
04/15/2016	1	Initial Issue	PC

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR and DWV/IR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR and DWV/IR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead free
- 9) Samtec Test PCBs used: PCB-107180-TST-XX, PCB-107208-TST-XX.

FLOWCHARTS

Gas Tight

Group 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

8 Assemblies

Step	Description
1.	LLCR (2)
2.	Gas Tight (1)
3.	LLCR (2) Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

Thermal Aging

Group 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (2)
3.	LLCR (1)
4.	Thermal Age (3)
5.	LLCR (1) Max Delta = 15 mOhm
6.	Mating/Unmating Force (2)
7.	Contact Gaps

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17

Test Condition = 4 (105°C)

Time Condition = B (250 Hours)

FLOWCHARTS Continued**Mating/Unmating/Durability**Group 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR ⁽²⁾
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾
10.	Cycles Quantity = 25 Cycles
11.	Mating/Unmating Force ⁽³⁾
12.	Contact Gaps
13.	LLCR ⁽²⁾ Max Delta = 15 mOhm
14.	Thermal Shock ⁽⁴⁾
15.	LLCR ⁽²⁾ Max Delta = 15 mOhm
16.	Humidity ⁽¹⁾
17.	LLCR ⁽²⁾ Max Delta = 15 mOhm
18.	Mating/Unmating Force ⁽³⁾

(1) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max

Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

Group 1
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 2
CCP-12-1-L-00.3-S-B-P

2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 3
CCR-12-1-L-00.3-T-B-P

2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 4
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
2 Assemblies

Step	Description
1.	IR (4)
2.	DWV at Test Voltage (1)
3.	Thermal Shock (5)
4.	IR (4)
5.	DWV at Test Voltage (1)
6.	Humidity (3)
7.	IR (4)
8.	DWV at Test Voltage (1)

Row-to-Row

Group 5
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 6
CCP-12-1-L-00.3-S-B-P

2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 7
CCR-12-1-L-00.3-T-B-P

2 Assemblies

Step	Description
1.	DWV Breakdown (2)

Group 8
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
2 Assemblies

Step	Description
1.	IR (4)
2.	DWV at Test Voltage (1)
3.	Thermal Shock (5)
4.	IR (4)
5.	DWV at Test Voltage (1)
6.	Humidity (3)
7.	IR (4)
8.	DWV at Test Voltage (1)

- (1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds
- (3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max
- (5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**Group 1

CCP-12-1-L-00.3-S-B-P
 CCR-12-1-L-00.3-T-B-P
 1 Pins Powered
 Signal

Step Description

1. CCC⁽¹⁾

Group 2

CCP-12-1-L-00.3-S-B-P
 CCR-12-1-L-00.3-T-B-P
 2 Pins Powered
 Signal

Step Description

1. CCC⁽¹⁾

Group 3

CCP-12-1-L-00.3-S-B-P
 CCR-12-1-L-00.3-T-B-P
 3 Pins Powered
 Signal

Step Description

1. CCC⁽¹⁾

Group 4

CCP-12-1-L-00.3-S-B-P
 CCR-12-1-L-00.3-T-B-P
 4 Pins Powered
 Signal

Step Description

1. CCC⁽¹⁾

Group 5

CCP-12-1-L-00.3-S-B-P
 CCR-12-1-L-00.3-T-B-P
 8 Pins Powered
 Signal

Step Description

1. CCC⁽¹⁾

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

8 Assemblies

Step Description

1. LLCR ⁽¹⁾
2. Mechanical Shock ⁽²⁾
3. Random Vibration ⁽³⁾
4. LLCR ⁽¹⁾
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23

Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) ⁽¹⁾
2. Nanosecond Event Detection
(Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued**Dust/Water****IPx7 Water Submersion**Group 1

CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
6 Assemblies

Step	Description
1.	Water Submersion - IPX7 (2) Depth = 1 meters
2.	Visual Inspection

Group 2

CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
6 Assemblies

Step	Description
1.	Water Submersion - IPX7 (2) Depth = 1 meters
2.	Visual Inspection

Group 3

DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
6 Assemblies

Step	Description
1.	Water Submersion - IPX7 (2) Depth = 1 meters
2.	Visual Inspection

IPx8 Deep Water SubmersionGroup 4

CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 2 meters Duration = 30 min
2.	Visual Inspection

Group 5

CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 2 meters
2.	Visual Inspection

Group 6

DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 2 meters Duration = 30 min
2.	Visual Inspection

Group 7

CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 3 meters
2.	Visual Inspection

Group 8

CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 3 meters Duration = 30 min
2.	Visual Inspection

Group 9

DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 3 meters
2.	Visual Inspection

Group 10

CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 4 meters Duration = 30 min
2.	Visual Inspection

Group 11

CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 4 meters
2.	Visual Inspection

FLOWCHARTS Continued

Group 12
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 4 meters Duration = 30 min
2.	Visual Inspection

Group 13
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 5 meters
2.	Visual Inspection

Group 14
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 5 meters Duration = 30 min
2.	Visual Inspection

Group 15
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 5 meters
2.	Visual Inspection

Group 16
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 6 meters Duration = 30 min
2.	Visual Inspection

Group 17
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 6 meters
2.	Visual Inspection

Group 18
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 6 meters Duration = 30 min
2.	Visual Inspection

Group 19
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 7 meters
2.	Visual Inspection

Group 20
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 7 meters
2.	Visual Inspection

Group 21
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 7 meters Duration = 30 min
2.	Visual Inspection

Group 22
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 8 meters
2.	Visual Inspection

Group 23
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 8 meters Duration = 30 min
2.	Visual Inspection

FLOWCHARTS Continued

Group 24
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 8 meters
2.	Visual Inspection

Group 25
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 9 meters Duration = 30 min
2.	Visual Inspection

Group 26
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 9 meters
2.	Visual Inspection

Group 27
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 9 meters
2.	Visual Inspection

Group 28
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Depth = 10 meters Duration = 30 min
2.	Visual Inspection

Group 29
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 10 meters
2.	Visual Inspection

Group 30
DCA-ACP-12-P-1
CCR-12-1-L-00.3-T-B-P
3 Assemblies

Step	Description
1.	Water Submersion - IPX8 (3) Duration = 30 min Depth = 10 meters
2.	Visual Inspection

IP6x Dust

Group 31
CCP-12-1-L-00.3-S-B-P
CCR-12-1-L-00.3-T-B-P
6 Assemblies

Step	Description
1.	Dust - IP6X (1)
2.	Visual Inspection

Group 32
CCP-12-1-L-00.3-S-B-P
DCA-ACP-12-P-1
6 Assemblies

Step	Description
1.	Dust - IP6X (1)
2.	Visual Inspection

Group 33
DCA-ACR-12-P-1
CCR-12-1-L-00.3-T-B-P
6 Assemblies

Step	Description
1.	Dust - IP6X (1)
2.	Visual Inspection

(1) Dust - IP6X = CEI/IEC 60529

(2) Water Submersion - IPX7 = CEI/IEC 60529

(3) Water Submersion - IPX8 = CEI/IEC 60529

FLOWCHARTS Continued**Cable Flex**Group 1

CCP-12-1-L-00.3-S-B-P

CCR-12-1-L-00.3-T-B-P

8 Assemblies

Circular Cable

Step	Description
1.	IR ⁽³⁾
2.	DWV at Test Voltage ⁽²⁾ Test Voltage = 500 V
3.	Cable Flex ⁽¹⁾
4.	Visual Inspection
5.	IR ⁽³⁾
6.	DWV at Test Voltage ⁽²⁾ Test Voltage = 500 V
7.	Rotate Cable 90°
8.	Cable Flex ⁽¹⁾
9.	Visual Inspection
10.	IR ⁽³⁾
11.	DWV at Test Voltage ⁽²⁾ Test Voltage = 500 V

(1) Cable Flex = EIA-364-41

Circular Jacket Cable - to be tested 90° each direction (180° total)

Flat Cable - to be tested 70° each direction (140° total)

Monitor continuity during flex testing

Failure = Discontinuity >1 microsecond at 10 ohms

(2) DWV at Test Voltage = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(3) IR = EIA-364-21

Test Condition = 500 Vdc, 2 Minutes Max

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

- 1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors*.
- 2) Test Condition 4 at 105° C.
- 3) Test Time Condition B for 250 hours.
- 4) All test samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

- 1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
- 2) Test Condition V, Letter B
- 3) Power Spectral Density: 0.04 G² / Hz
- 4) G 'RMS': 7.56
- 5) Frequency: 50 to 2000 Hz
- 6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

- 1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
- 2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
- 3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at four temperature points are reported:
 - a. Ambient
 - b. 85° C
 - c. 95° C
 - d. 115° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms:----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003” to 0.004” of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

- 8) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 9) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 10) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms:----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure
- 11) Procedure:
 - a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
 - b. Test Conditions:
 - i. Class II-- Mated pairs of contacts assembled to their plastic housings.
 - ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
 - iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
 - iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
 - v. Exposure time, 55 to 65 minutes.
 - vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
 - vii. The samples shall be dried after exposure for a minimum of 1 hour.
 - viii. Drying temperature 50° C
 - ix. The final LLCR shall be conducted within 1 hour after drying.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 1000 megohms.

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

1) PROCEDURE:

- a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
- b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs

2) MEASUREMENTS/CALCULATIONS

- a. The breakdown voltage shall be measured and recorded.
- b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
- c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

WATER TESTING:

- 1) Reference document: CEI/IEC 60529 Code IPX7 and IPX8
- 2) CCR torque specification for SCPN-16-M is 15~20 IN-LB
- 3) CCP torque specification for ACCN-16-M onto ACCFS-16-M-X is 10~15 IN-LB

DUST TESTING:

- 1) Reference document: CEI/IEC 60529 Code IP6X
- 2) CCR torque specification for SCPN-16-M is 15~20 IN-LB
- 3) CCP torque specification for ACCN-16-M onto ACCFS-16-M-X is 10~15 IN-LB

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

CABLE PULL:

- 1) Secure cable near center and pull on connector
 - a. At 90° , right angle to cable
 - b. At 0° , in-line with cable

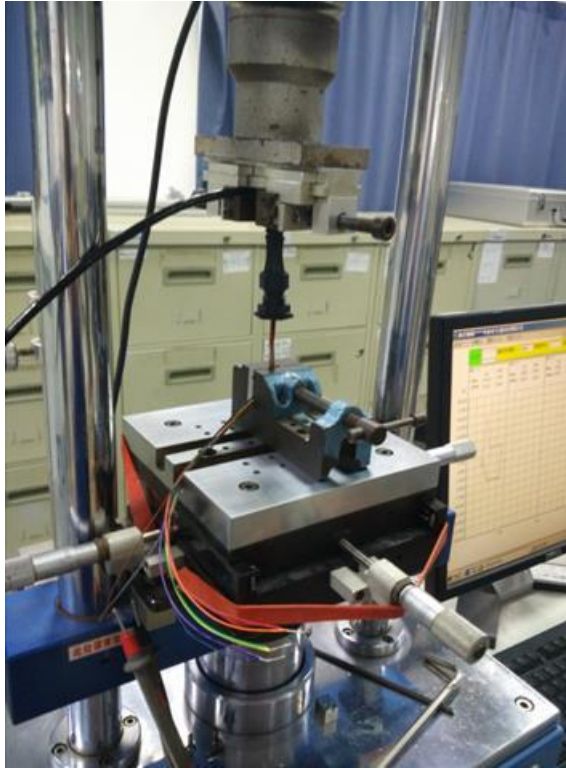


Fig. 1

0° Connector pull, notice the electrical continuity hook-up wires.

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

CABLE Flex:

- 1) Oscillate and monitor electrical continuity for open circuit indication.
 - a. $\pm 90^\circ$ Pendulum Mode, bend up to 200 cycles with 16 oz. load on cable end.



Fig. 2

RESULTS

Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise-----3.6 A per contact with 1 contacts (1x1) powered
- CCC for a 30°C Temperature Rise-----3.0 A per contact with 2 contacts (1x2) powered
- CCC for a 30°C Temperature Rise-----2.6 A per contact with 3 contacts (1x3) powered
- CCC for a 30°C Temperature Rise-----2.2 A per contact with 4 contacts (1x4) powered
- CCC for a 30°C Temperature Rise-----1.6 A per contact with 8 contacts (1x8) powered

Mating/Unmating Forces: Thermal Aging Group

- **Initial**
 - **Mating**
 - **Min** ----- 0.95 Lbs
 - **Max**----- 1.25Lbs
 - **Unmating**
 - **Min** ----- 0.69 Lbs
 - **Max**----- 0.87 Lbs
- **After Thermal**
 - **Mating**
 - **Min** ----- 0.62 Lbs
 - **Max**----- 0.88 Lbs
 - **Unmating**
 - **Min** ----- 0.57 Lbs
 - **Max**----- 0.68 Lbs

RESULTS Continued**Mating/Unmating Forces: Mating/Unmating Durability Group**

- **Initial**
 - **Mating**
 - **Min** ----- 0.97 Lbs
 - **Max** ----- 1.39 Lbs
 - **Unmating**
 - **Min** ----- 0.57 Lbs
 - **Max** ----- 0.89 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 0.87 Lbs
 - **Max** ----- 1.30 Lbs
 - **Unmating**
 - **Min** ----- 0.56 Lbs
 - **Max** ----- 0.84 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 0.83 Lbs
 - **Max** ----- 1.21 Lbs
 - **Unmating**
 - **Min** ----- 0.59 Lbs
 - **Max** ----- 0.75 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 0.83 Lbs
 - **Max** ----- 1.22 Lbs
 - **Unmating**
 - **Min** ----- 0.59 Lbs
 - **Max** ----- 0.75 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 0.85 Lbs
 - **Max** ----- 1.21 Lbs
 - **Unmating**
 - **Min** ----- 0.59 Lbs
 - **Max** ----- 0.76 Lbs
- **After Humidity**
 - **Mating**
 - **Min** ----- 0.64 Lbs
 - **Max** ----- 0.79 Lbs
 - **Unmating**
 - **Min** ----- 0.45 Lbs
 - **Max** ----- 0.58 Lbs

RESULTS Continued**Cable pull force:**

- 0° Pull
 - Min -----25.59 Lbs
 - Max-----32.69 Lbs
- 90° Pull
 - Min -----35.50 Lbs
 - Max-----45.40 Lbs

Insulation Resistance minimums, IR**Pin to pin**

- Initial
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- Thermal Shock
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed
- Humidity
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- Minimums
 - Breakdown Voltage----- 1350VAC
 - Test Voltage ----- 1010 VAC
 - Working Voltage -----340 VAC

Pin to Pin

- Initial DWV -----Passed
- Thermal DWV-----Passed
- Humidity DWV-----Passed

CABLE FLEX**Insulation Resistance minimums, IR****Pin to Pin**

- Initial
 - Mated-----45000 Meg Ω ----- Passed
- After flex 100 cycles
 - Mated-----45000 Meg Ω ----- Passed
- After flex 200 cycles
 - Mated-----45000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- Minimums
 - Breakdown Voltage----- 1200 VAC
 - Test Voltage -----900 VAC
 - Working Voltage -----300 VAC

Pin to Pin

- Initial DWV -----Passed
- After Flex 100 cycles DWV -----Passed
- After Flex 200 cycles DWV -----Passed

Supplemental – Cable Bend 200 Cycles

- $\pm 90^\circ$ Flex Mode ----- No Electrical Failures

RESULTS Continued**LLCR Gas Tight (64 LLCR test points)**

- **Initial** ----- 86.06 mOhms Max
- **Gas-Tight**
 - <= +5.0 mOhms ----- 64 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

LLCR Thermal Aging (64 LLCR test points)

- **Initial** ----- 90.83 mOhms Max
- **Thermal Aging**
 - <= +5.0 mOhms ----- 61 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 3 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

LLCR Durability (64 LLCR test points)

- **Initial** ----- 90.15 mOhms Max
- **Durability, 100 Cycles**
 - <= +5.0 mOhms ----- 64 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 0 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Thermal Shock**
 - <= +5.0 mOhms ----- 61 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 3 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure
- **Humidity**
 - <= +5.0 mOhms ----- 62 Points ----- Stable
 - +5.1 to +10.0 mOhms ----- 2 Points ----- Minor
 - +10.1 to +15.0 mOhms ----- 0 Points ----- Acceptable
 - +15.1 to +50.0 mOhms ----- 0 Points ----- Marginal
 - +50.1 to +2000 mOhms ----- 0 Points ----- Unstable
 - >+2000 mOhms ----- 0 Points ----- Open Failure

RESULTS Continued**LLCR Shock & Vibration (64 LLCR test points)**

- **Initial -----132.60 mOhms Max**
- **Shock & Vibration**
 - **<= +5.0 mOhms -----60 Points ----- Stable**
 - **+5.1 to +10.0 mOhms -----4 Points ----- Minor**
 - **+10.1 to +15.0 mOhms -----0 Points ----- Acceptable**
 - **+15.1 to +50.0 mOhms -----0 Points ----- Marginal**
 - **+50.1 to +2000 mOhms -----0 Points ----- Unstable**
 - **>+2000 mOhms -----0 Points ----- Open Failure**

Mechanical Shock & Random Vibration:

- **Shock**
 - **No Damage----- Pass**
 - **50 Nanoseconds----- Pass**
- **Vibration**
 - **No Damage----- Pass**
 - **50 Nanoseconds----- Pass**

RESULTS Continued**IP67 Testing (Dust&Water)****Group A1 (CCP/CCR)**

Dust	<u>Initial (Before Exposure)</u> No Dust Present	<u>After Exposure</u> No Dust Present
-------------	-------------------------------------------------------------------	--------------------------------------------------------

Group A2 (CCP/CCR)

Water	<u>Initial (Before Exposure)</u> No water Present	<u>After Exposure</u> No water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

Group B1 (CCP/DCA)

Dust	<u>Initial (Before Exposure)</u> No Dust Present	<u>After Exposure</u> No Dust Present
-------------	-------------------------------------------------------------------	--------------------------------------------------------

Group B2 (CCP/DCA)

Water	<u>Initial (Before Exposure)</u> No water Present	<u>After Exposure</u> No water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

Group C1 (CCR/DCA)

Dust	<u>Initial (Before Exposure)</u> No Dust Present	<u>After Exposure</u> No Dust Present
-------------	-------------------------------------------------------------------	--------------------------------------------------------

Group C2 (CCR/DCA)

Water	<u>Initial (Before Exposure)</u> No water Present	<u>After Exposure</u> No water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

IPX8 Testing (Water)**Group A3 (CCP/CCR-10 m)**

Water	<u>Initial (Before Exposure)</u> No Water Present	<u>After Exposure</u> No Water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

Group B3 (CCP/DCA-10 m)

Water	<u>Initial (Before Exposure)</u> No Water Present	<u>After Exposure</u> No Water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

Group C3 (CCR/DCA-9 m)

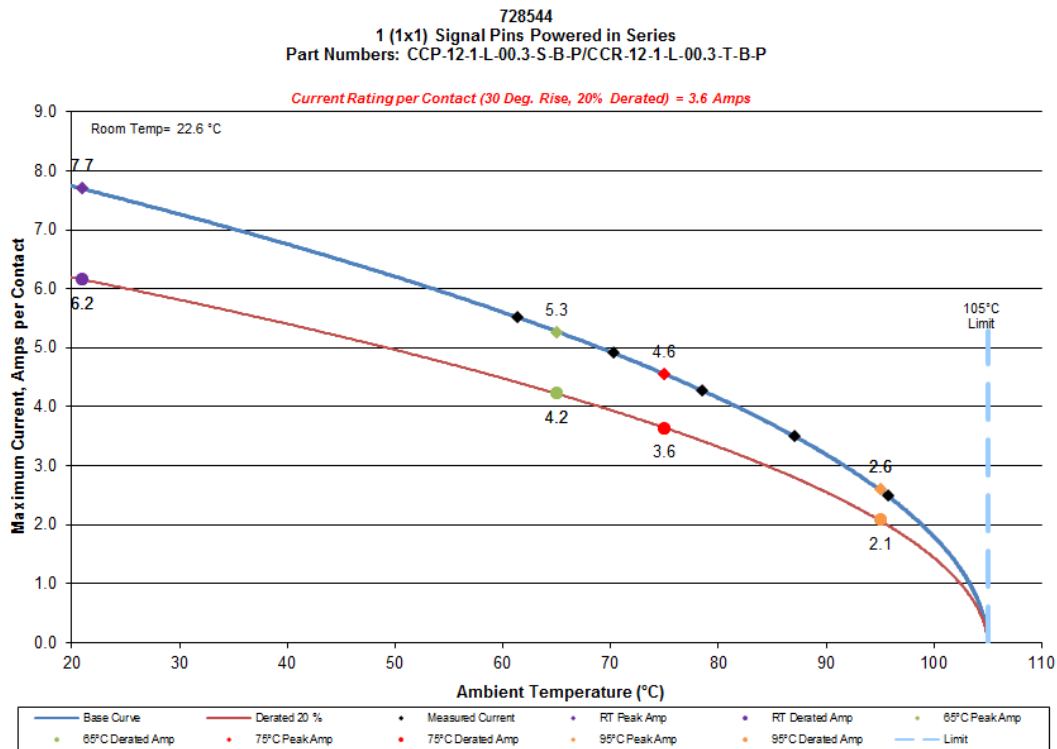
Water	<u>Initial (Before Exposure)</u> No Water Present	<u>After Exposure</u> No Water Present
--------------	--------------------------------------------------------------------	---------------------------------------------------------

DATA SUMMARIES

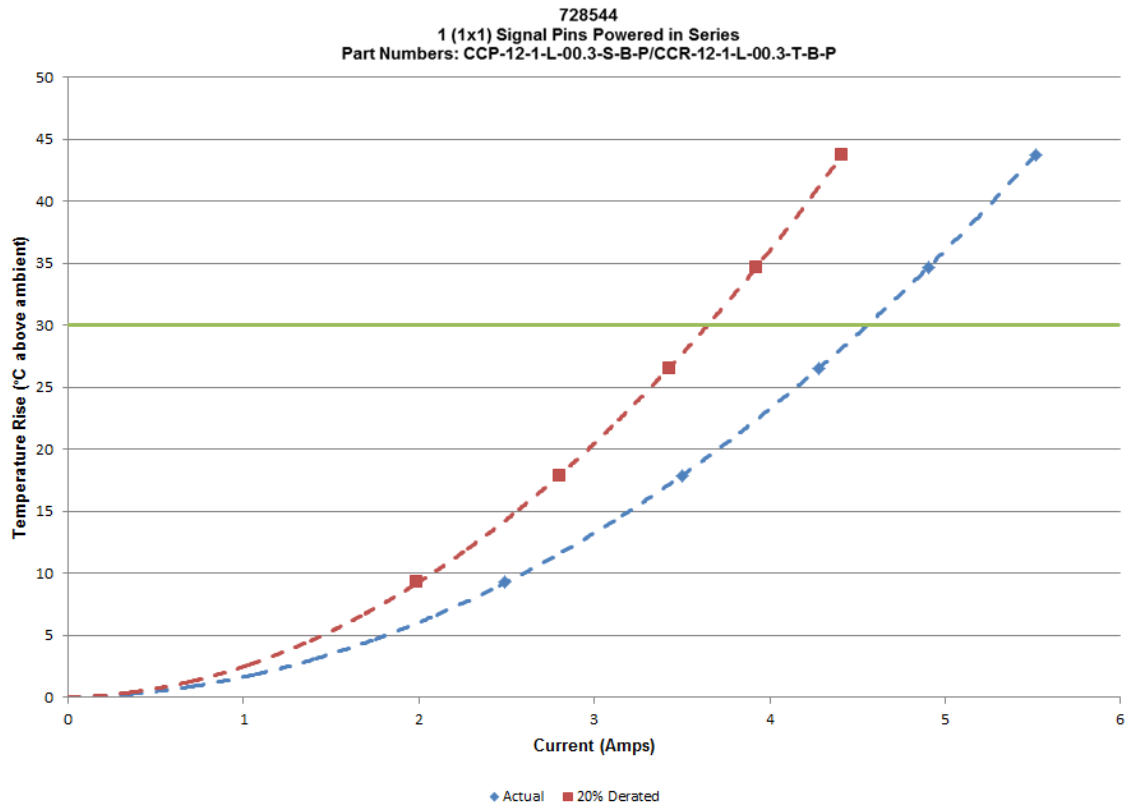
TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:

- a. Linear configuration with 1 adjacent conductors/contacts powered



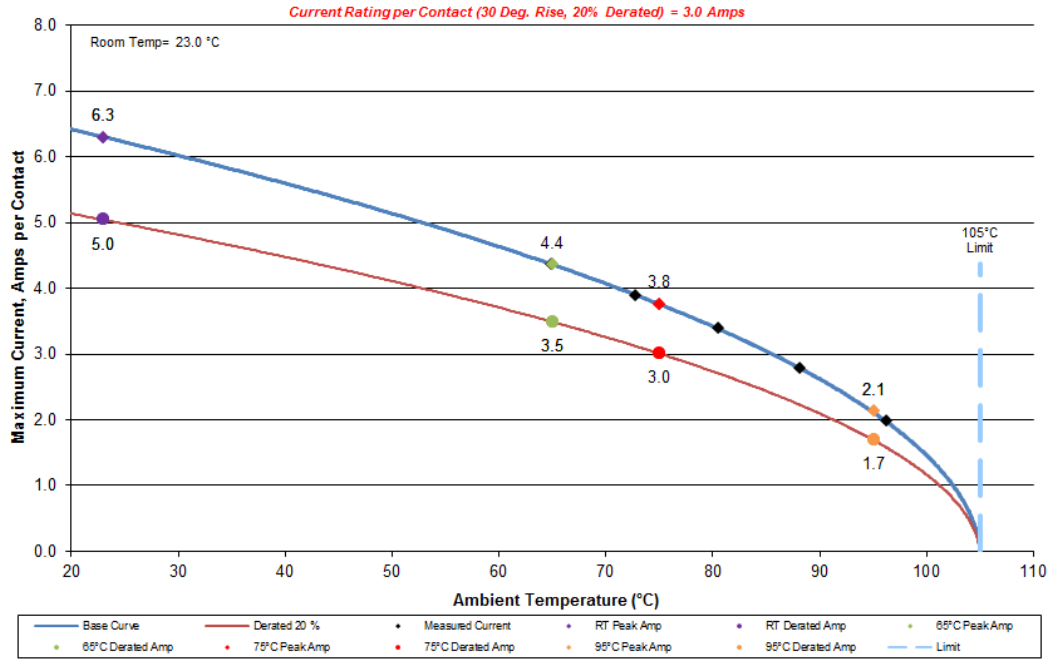
DATA SUMMARIES Continued



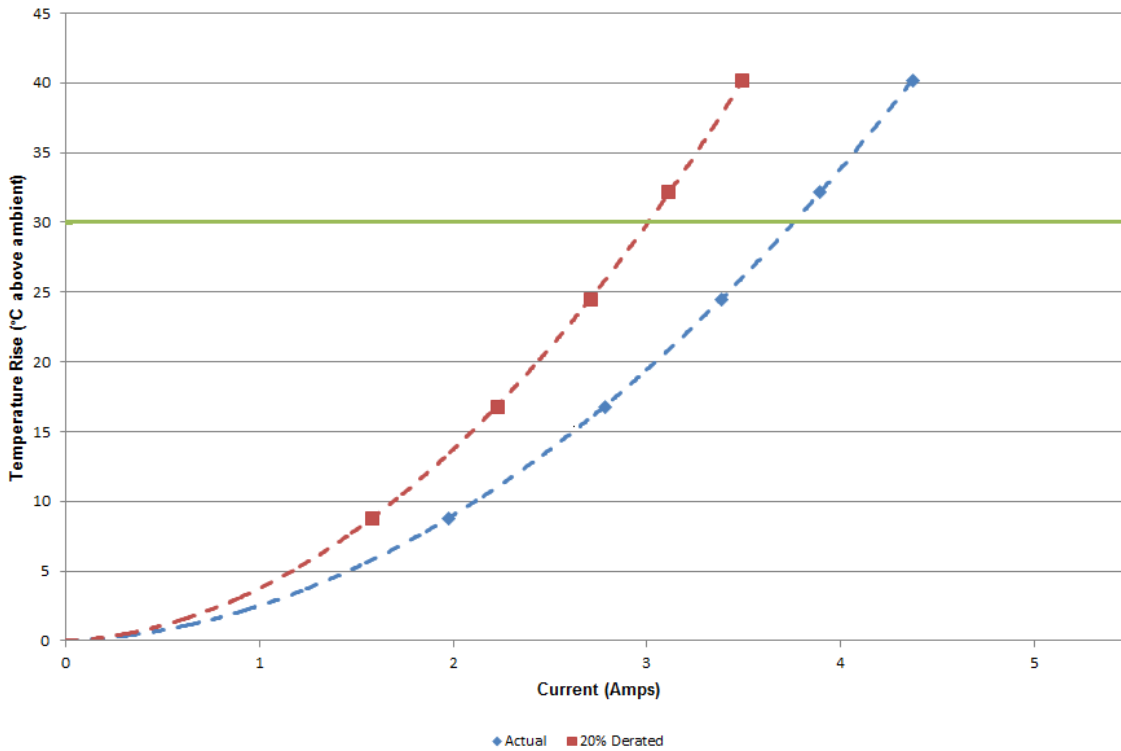
DATA SUMMARIES Continued

b. Linear configuration with 2 adjacent conductors/contacts powered

728544
2 (1x2) Signal Pins Powered in Series
Part Numbers: CCP-12-1-L-00.3-S-B-P/CCR-12-1-L-00.3-T-B-P

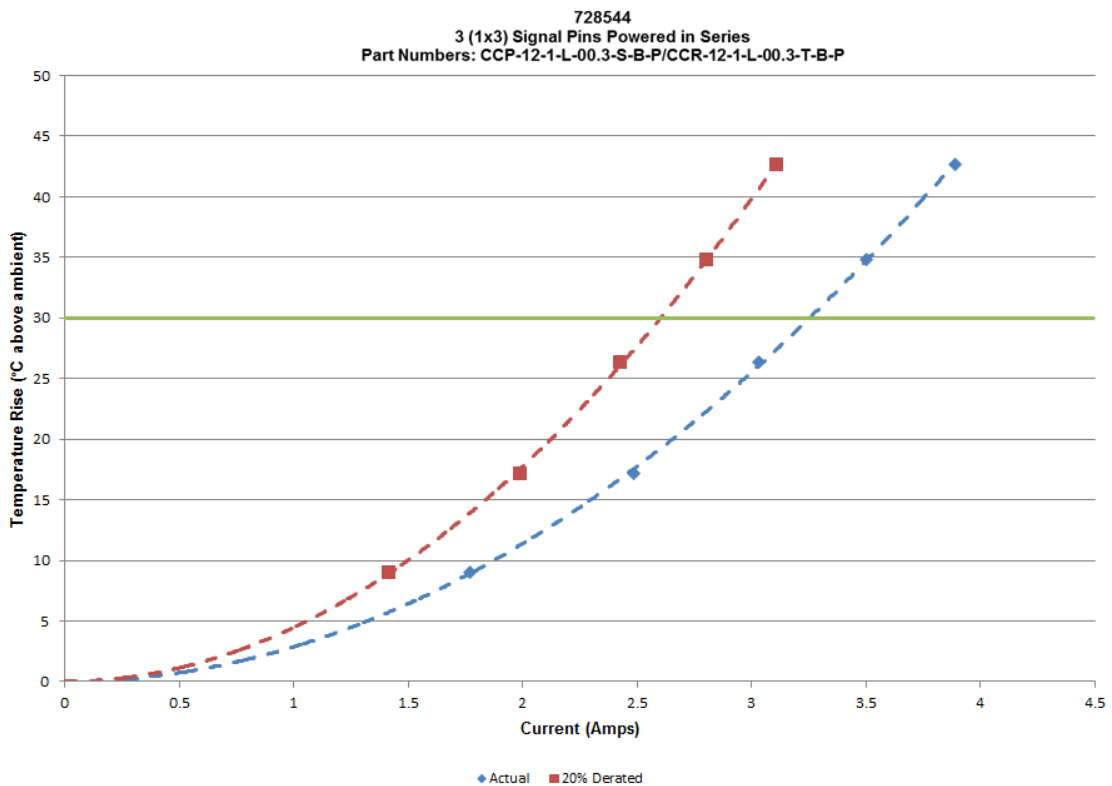
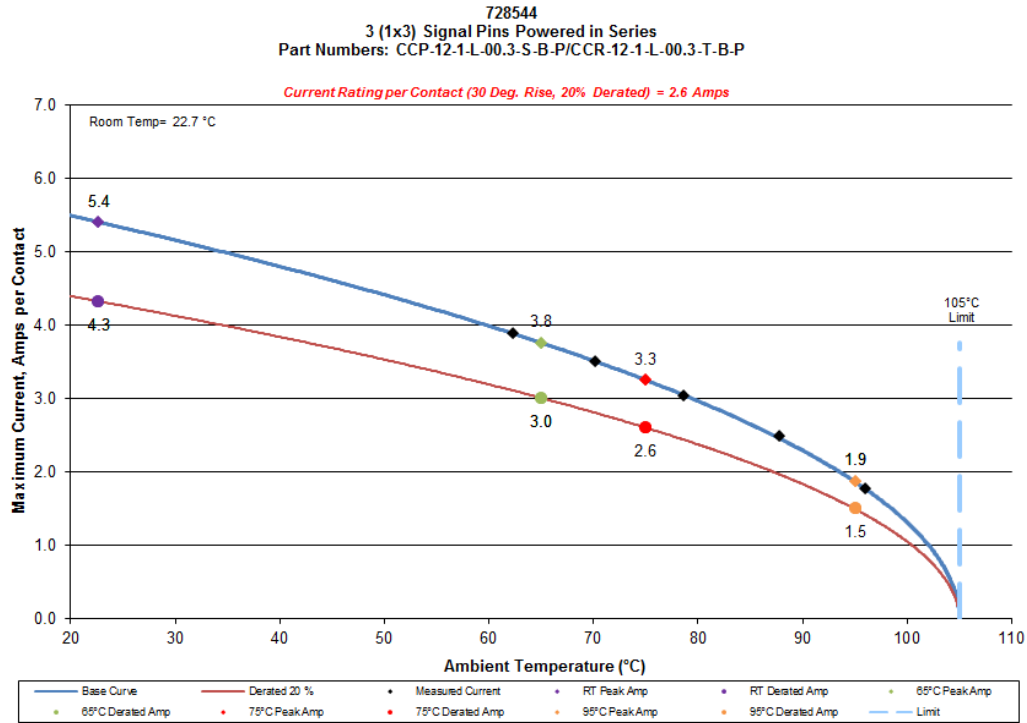


728544
2 (1x2) Signal Pins Powered in Series
Part Numbers: CCP-12-1-L-00.3-S-B-P/CCR-12-1-L-00.3-T-B-P



DATA SUMMARIES Continued

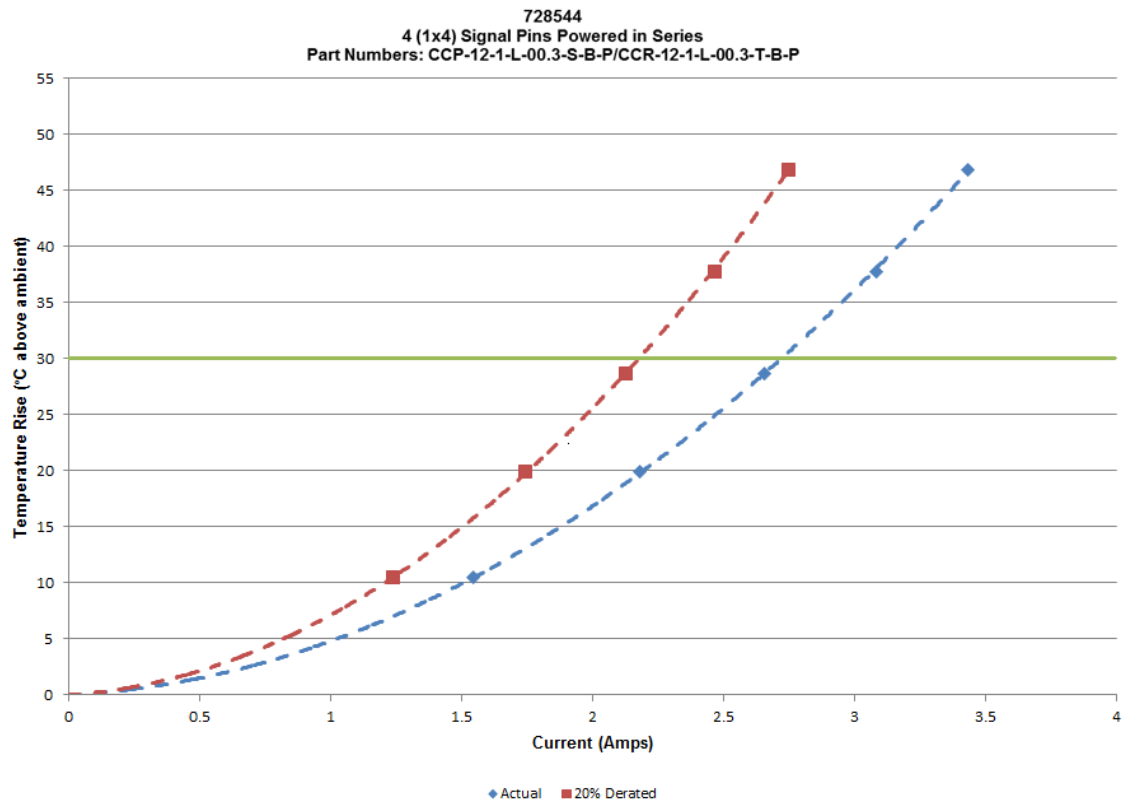
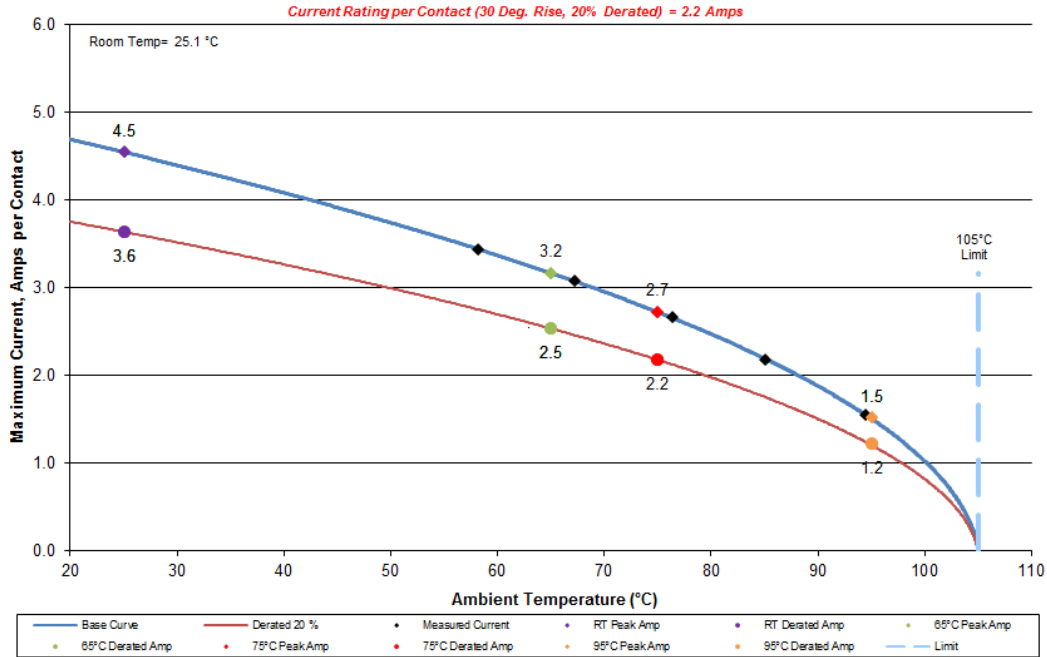
c. Linear configuration with 3 adjacent conductors/contacts powered



DATA SUMMARIES Continued

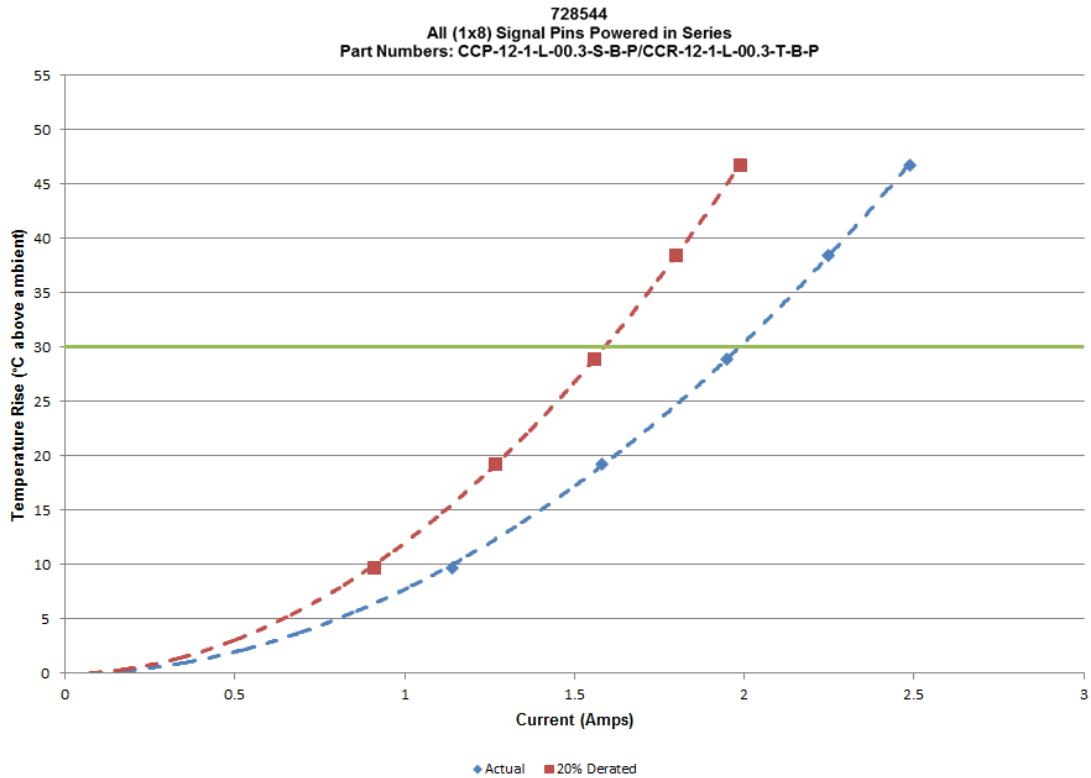
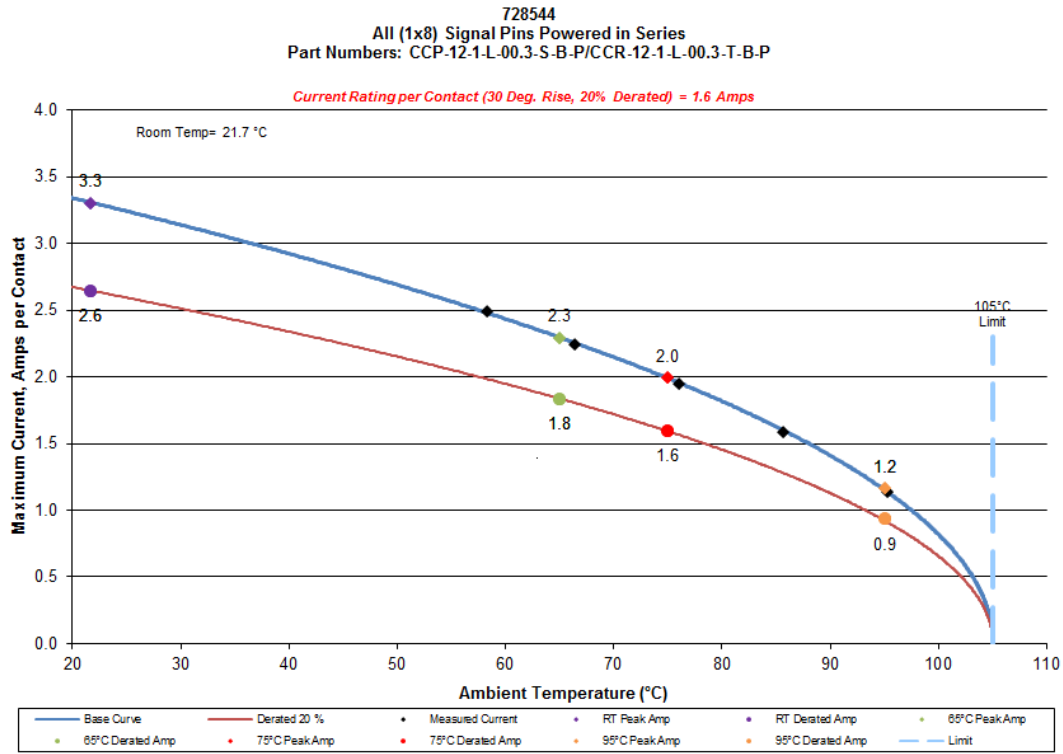
d. Linear configuration with 4 adjacent conductors/contacts powered

728544
4 (1x4) Signal Pins Powered in Series
Part Numbers: CCP-12-1-L-00.3-S-B-P/CCR-12-1-L-00.3-T-B-P



DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered



DATA SUMMARIES**Mating\Unmating Force: Thermal Aging Group**

	Initial				After Thermals			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	4.23	0.95	3.07	0.69	2.76	0.62	2.54	0.57
Maximum	5.56	1.25	3.87	0.87	3.91	0.88	3.02	0.68
Average	4.88	1.10	3.36	0.76	3.48	0.78	2.74	0.62
St Dev	0.47	0.11	0.32	0.07	0.35	0.08	0.21	0.05
Count	8	8	8	8	8	8	8	8

Mating\Unmating Force: Mating\Unmating Durability Group

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	4.31	0.97	2.54	0.57	3.87	0.87	2.49	0.56
Maximum	6.18	1.39	3.96	0.89	5.78	1.30	3.74	0.84
Average	5.00	1.12	3.20	0.72	4.93	1.11	3.05	0.69
St Dev	0.60	0.14	0.48	0.11	0.64	0.14	0.47	0.11
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	3.69	0.83	2.62	0.59	3.69	0.83	2.62	0.59
Maximum	5.38	1.21	3.34	0.75	5.43	1.22	3.34	0.75
Average	4.54	1.02	2.92	0.66	4.41	0.99	2.94	0.66
St Dev	0.53	0.12	0.25	0.06	0.55	0.12	0.25	0.06
Count	8	8	8	8	8	8	8	8

	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	3.78	0.85	2.62	0.59	2.85	0.64	2.00	0.45
Maximum	5.38	1.21	3.38	0.76	3.51	0.79	2.58	0.58
Average	4.43	1.00	2.92	0.66	3.27	0.74	2.21	0.50
St Dev	0.52	0.12	0.27	0.06	0.27	0.06	0.23	0.05
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**Cable pulls force:****0° Pull**

	Force (lbs)
Minimum	25.59
Maximum	32.69
Average	29.13

90° Pull

	Force (lbs)
Minimum	35.50
Maximum	45.40
Average	40.55

INSULATION RESISTANCE (IR):

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	CCP/CCR	CCP	CCR
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	CCP/CCR
Break Down Voltage	1350
Test Voltage	1010
Working Voltage	340

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**CABLE FLEX
INSULATION RESISTANCE (IR)**

Pin to Pin	
Unmated	
Minimum	
Initial	45000
After 100 Flex Cycles	45000
After 200 Flex Cycles	45000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary (Determined by Cable Rating)	
Minimum	
Break Down Voltage	1200
Test Voltage	900
Working Voltage	300

Pin to Pin	
Initial Test Voltage	Passed
After 100 Flex Cycles Test Voltage	Passed
After 200 Flex Cycles Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Durability:**

- 1) A total of 64 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	11/23/2015	11/26/2015	12/2/2015	12/16/2015
Room Temp (Deg C)	23	23	23	23
Rel Humidity (%)	54	54	50	54
Technician	Peter Chen	Peter Chen	Peter Chen	Peter Chen
mOhm values	Actual	Delta	Delta	Delta
	Initial	100 Cycles	Therm Shck	Humidity
Pin Type 1: Signal				
Average	84.42	0.59	1.37	1.25
St. Dev.	1.19	0.58	1.68	1.47
Min	81.87	0.03	0.00	0.02
Max	90.15	3.43	8.66	8.98
Summary Count	64	64	64	64
Total Count	64	64	64	64

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
100 Cycles	64	0	0	0	0	0
Therm Shck	61	3	0	0	0	0
Humidity	62	2	0	0	0	0

DATA SUMMARIES Continued**LLCR Thermal Aging:**

- 1) A total of 64 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms:----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	11/26/2015	12/9/2015		
Room Temp (Deg C)	23	23		
Rel Humidity (%)	53	54		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual Initial	Delta Thermal	Delta	Delta
Pin Type 1: Signal				
Average	85.79	2.75		
St. Dev.	1.61	1.51		
Min	82.05	0.04		
Max	90.83	7.93		
Summary Count	64	64		
Total Count	64	64		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Thermal	61	3	0	0	0	0

DATA SUMMARIES Continued**LLCR Gas Tight:**

- 1) A total of 20 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms: ----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	12/9/2015	12/10/2015		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	56	56		
Technician	Peter Chen	Peter Chen		
mOhm values	Actual Initial	Delta Acid Vapor	Delta	Delta
Pin Type 1: Signal				
Average	81.31	1.71		
St. Dev.	1.77	0.75		
Min	78.83	0.36		
Max	86.06	4.22		
Summary Count	64	64		
Total Count	64	64		

LLCR Delta Count by Category						
mOhms	Stable	Minor	Acceptable	Marginal	Unstable	Open
	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Acid Vapor	64	0	0	0	0	0

DATA SUMMARIES Continued**LLCR Shock &Vibration:**

- 1). A total of 16 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms: ----- Minor
 - c. $+10.1$ to $+15.0$ mOhms:----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:----- Marginal
 - e. $+50.1$ to $+2000$ mOhms----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	1/21/2016	1/29/2016		
Room Temp (Deg C)	23	23		
Rel Humidity (%)	32	35		
Technician	Aaron McKim	Aaron McKim		
mOhm values	Actual Initial	Delta Shock-Vib	Delta	Delta
Pin Type 1: Signal				
Average	129.69	1.20		
St. Dev.	1.11	1.69		
Min	127.56	0.03		
Max	132.60	7.97		
Summary Count	64	64		
Total Count	64	64		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Shock-Vib	60	4	0	0	0	0

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	16
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

DATA SUMMARIES Continued**IP67 Testing (Dust&Water)****Dust:****Group A1 (CCP/CCR)**

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

Group B1 (CCP/DCA)

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

Group C1 (CCR/DCA)

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

DATA SUMMARIES Continued**Water****Group A2 (CCP/CCR)**

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

Group B2 (CCP/DCA)

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

Group C2 (CCR/DCA)

Sample #	Visual Inspection
1	PASS
2	PASS
3	PASS
4	PASS
5	PASS
6	PASS

DATA SUMMARIES Continued**IPX8 Testing
CCP/CCR**

Sample #	Visual Inspection at 10 Meters
37	PASS
38	PASS
39	PASS

CCP/DCA

Sample #	Visual Inspection at 10 Meters
37	PASS
38	PASS
39	PASS

CCR/DCA

Sample #	Visual Inspection at 10 Meters
37	PASS
38	PASS
39	FAIL

CCR/DCA

Sample #	Visual Inspection at 9 Meters
37	PASS
38	PASS
39	PASS

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-HPM-01**Description:** IR/DWV Tester**Manufacturer:** AN9636H**Model:** AN9636H**Serial #:** 089601091**Accuracy:** Last Cal: 2015-7-6, Next Cal: 2016-7-5**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 2015-4-28, Next Cal: 2016-4-27**Equipment #:** HZ-OV-01**Description:** Oven**Manufacturer:** Huida**Model:** CS101-1E**Serial #:** CS101-1E-B**Accuracy:** Last Cal: 2015-12-14, Next Cal: 2016-12-13**Equipment #:** HZ-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** HMM30C**Serial #:** D0240037**Accuracy:** Last Cal: 2016-3-3, Next Cal: 2017-3-2**Equipment #:** HZ-TSC-01**Description:** Thermal Shock transmitter**Manufacturer:** CSZ**Model:** 10-VT14994**Serial #:** VTS-3-6-6-SC/AC**Accuracy:** Last Cal: 2015-11-1, Next Cal: 2016-11-1**Equipment #:** HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 297288**Accuracy:** Last Cal: 2015-8-6, Next Cal: 2016-8-5

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** MO-02**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 0780546**Accuracy:** Last Cal: 2015-6-16, Next Cal: 2016-6-16**Equipment #:** PS-01**Description:** Power Supply**Manufacturer:** Hewlett Packard**Model:** 6033A**Serial #:** 3329A-07330**Accuracy:** Last Cal: 2015-6-12, Next Cal: 2016-6-12**Equipment #:** PS-02**Description:** Power Supply**Manufacturer:** Hewlett Packard**Model:** 6033A**Serial #:** 2847A-04167**Accuracy:** Last Cal: 2015-6-12, Next Cal: 2016-6-12**Equipment #:** SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 2015-11-31, Next Cal: 2016-11-31

Equipment #: ACLM-01**Description:** Accelerometer**Manufacturer:** PCB Piezotronics**Model:** 352C03**Serial #:** 115819**Accuracy:** See Manual

... Last Cal: 2015-07-9, Next Cal: 2016-7-9

Equipment #: ED-03**Description:** Event Detector**Manufacturer:** Analysis Tech**Model:** 32EHD**Serial #:** 1100604**Accuracy:** See Manual

... Last Cal: 2015-06-4, Next Cal: 2016-06-4